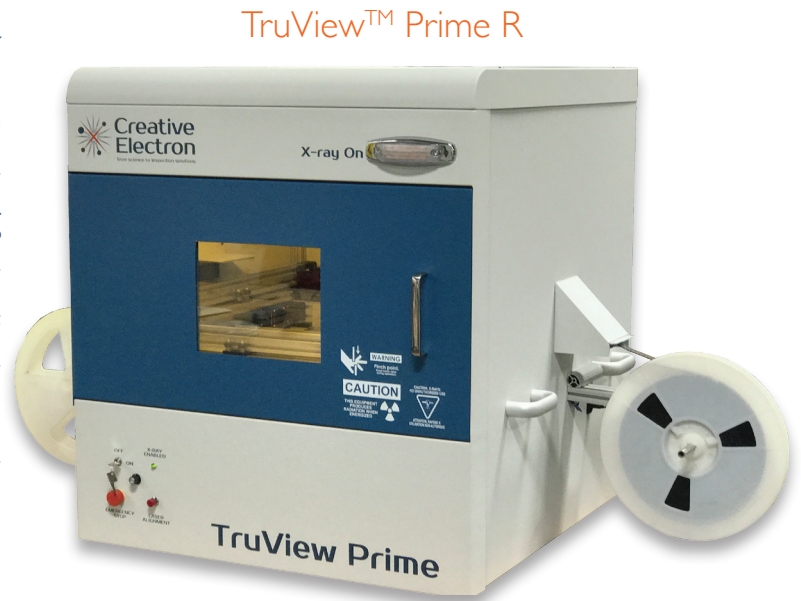


TruView™ Prime X-Ray System

Proudly designed and made in USA



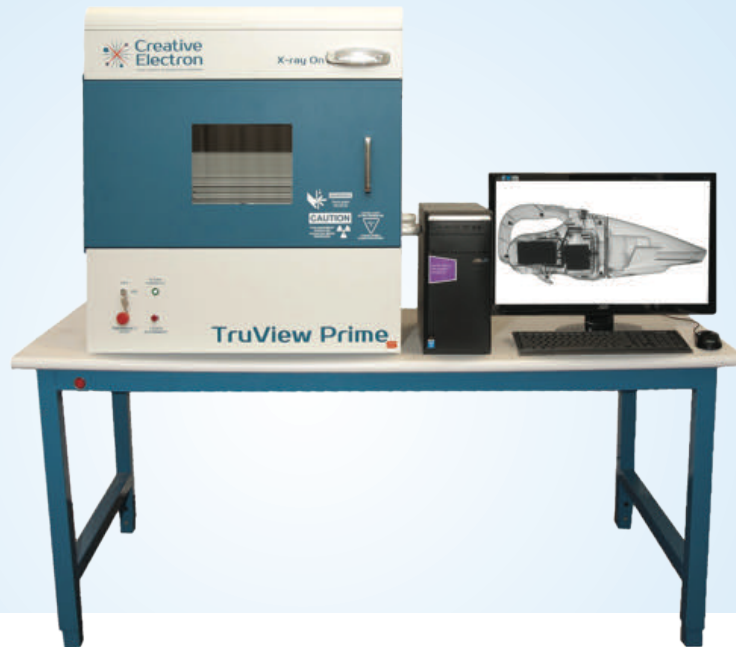
For several years technical teams had to make a decision: to buy a large x-ray inspection system for good image quality, or to buy a benchtop x-ray system for low image quality. The TruView™ Prime breaks this paradigm by offering outstanding image quality in a benchtop configuration. The TruView™ Prime is ideal for use in PCB inspection (BGA and QFN) or semiconductor failure analysis. The TruView™ Prime S is the ideal parts counter system.



ONE PLATFORM | THREE POWERFUL CONFIGURATIONS

Contact us today for a free evaluation of your samples

TruView™ Prime S



TECHNICAL SPECIFICATIONS:

X-ray Source: 80kV, 90kV, or 130kV

Spot Size: Microfocus

System Resolution: Final image resolution depends on sample

X-ray Sensor: 3" x 4" or 5" x 6" (A,R) 14-bit flat panel
12" x 10" or 17" x 17" (S) 16-bit flat panel

Sample Manipulation: Motorized or automated X,Y,Z motion.

Stage tilt and sample rotation are available as options. (A, R)

System Dimensions: 31" x 31" x 35" (A,S)
71" x 31" x 35" (R)

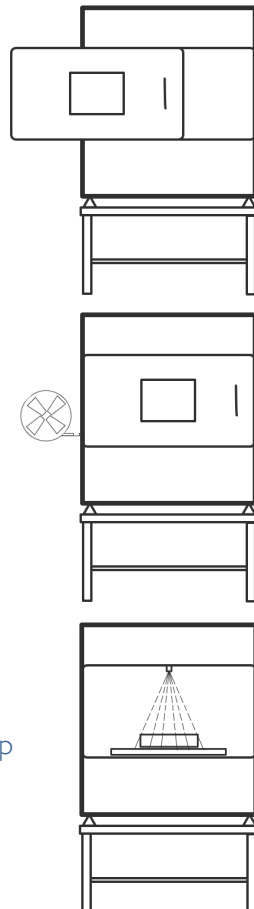
Max. Visible Area: 12" x 12" (A,R)
17" x 17" (S)

Included Software: TruView 6 Software. Please check TruView App Store for available applications.

Included Computer: PC with Windows OS, fully networkable

Safety: FDA compliant and CE certified. Cabinet fully shielded with multiple interlocks, keyed start switch, and emergency stop switch. Certified to operate worldwide

CONFIGURATIONS:



TruView™ Prime A

Load and unload your samples using the front door in the system. Motorized or automated motion system.

TruView™ Prime R

Automated inspection of components in tape and reel. A must have for component inspection and counterfeit detection.

TruView™ Prime S

Source on the top of the system and a large flat panel detector on the bottom, allowing your samples to lay right on top of the sensor. Ideal for NDT applications and parts counting.